


<b>Search Notes</b>  	<b>Application/Control No.</b>  10539926	<b>Applicant(s)/Patent Under Reexamination</b>  ISHIDU ET AL.
	<b>Examiner</b>  Tran, Thien F	<b>Art Unit</b>  2811

SEARCHED			
Class	Subclass	Date	Examiner
257	99, 100	09/19/2007	TT
above	updated	11/12/2007	TT

SEARCH NOTES			
Search Notes		Date	Examiner
Search history printout		09/19/2007	TT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	99	11/12/2007	TT